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# SHORT COMMUNICATIONS

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Acta Cryst. (1990). C46, 172-173

Structure of the zeolite theta-1. Redetermination using single-crystal synchrotron-radiation data. By M. Z. PAPIZ and S. J. ANDREWS, SERC Daresbury Laboratory, Warrington WA4 4AD, England, A. M. DAMAS and MARJORIE M. HARDING, Chemistry Department, Liverpool University, PO Box 147, Liverpool L69 3BX, England and RONA M. HIGHCOCK, BP Research Centre, Chertsey Road, Sunbury on Thames, Middlesex TW16 7LN, England

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## Abstract

Single-crystal synchrotron-radiation data have been recorded, using an area detector, for a crystal of dimensions  $4 \times 8 \times 125 \,\mu$ m, composition SiO<sub>2</sub>, and the structure redetermined. R = 0.116 for 394 reflections with  $F > 6\sigma(F)$ . The unit cell, and the framework of SiO<sub>4</sub> tetrahedra, sharing corners, with channels parallel to c, previously established from powder diffraction data by Highcock, Smith & Wood [Acta Cryst. (1985), C41, 1391–1394] is confirmed, but atom positions (z parameters) are revised by 0.1-2 Å.  $M_r = 60.1$ ,  $Cmc2_1$ , a = 13.836 (3), b = 17.415 (4), c = 5.042 (1) Å, V = 1215 Å<sup>3</sup>, Z = 24,  $\lambda = 0.914$  Å.

## Introduction

For the zeolite theta-1, large enough crystals for singlecrystal data measurement with a conventional X-ray source were not obtainable so structure determination was attempted from X-ray powder diffraction data (Highcock, Smith & Wood, 1985). The high intensity of a synchrotron source (SRS) and an area detector diffractometer have now allowed single-crystal data collection, from which the structure has been redetermined.

#### Experimental

Needle crystals of theta-1 were of uniform size,  $ca 4 \times 8 \times 125 \,\mu\text{m}$ . The Enraf–Nonius 'FAST' area detector diffrac-

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tometer on workstation 9.6 at SERC Daresbury Laboratory was used, with the SRS running at 2 GeV, 150 mA. The procedures for data collection and processing using *MADNES* software (Messerschmidt & Pflugrath, 1987) were very similar to those described for piperazine silicate (Andrews *et al.*, 1988). 100° of data were recorded about each of two rotation axes in the crystal, at 45° to each other. The first set alone included 785 observations, which merged to 331 independent reflections with a merging *R* (on intensity) of 0.06; the crystal rocking width was 2°. For the second orientation the rocking width appeared to be 10°; addition of these 463 observations to the earlier set yielded 486 independent reflection intensities with a merging *R* of 0.08, to a resolution of 1 Å.

The primitive monoclinic unit cell found initially with a = 10.944 (20), b = 10.970 (24), c = 4.958 (10) Å,  $\alpha = \beta = 90^{\circ}$ ,  $\gamma = 76.615$  (86)° and assuming  $\lambda = 0.90$  (1) Å, was converted into an orthorhombic cell; the latter is in agreement with that of Highcock, Smith & Wood (1985), a = 13.836 (3), b = 17.415 (4), c = 5.042 (1) Å, assuming  $\lambda = 0.914$  Å. Since there was some uncertainty in the precise value of the wavelength used on workstation 9.6, the latter cell dimensions and wavelength were used in the analysis. The systematic absences observed for the orthorhombic cell are also in agreement with space group  $Cmc2_1$ , 24 SiO<sub>2</sub> per unit cell, chosen by Highcock, Smith & Wood.

The structure was solved with the direct-methods facility of *SHELX*86 (Sheldrick, 1986) and refined (*SHELX*76; Sheldrick, 1976) with anisotropic vibration parameters for

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Table 1. Fractional coordinates of atoms with e.s.d.'s

$U_{eq} = \frac{1}{2}$	$(U_{11} + )$	$U_{22} +$	$U_{33}$ ).
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	x	у	z	$U_{eq}(\text{\AA}^2)$
Si(1)	0.2947 (6)	0.0490 (4)	0.2500	0.065 (4)
Si(2)	0.2056 (5)	0.2116 (4)	0.329 (2)	0.065 (4)
Si(3)	0.5000	0.2257 (6)	0.725 (3)	0.063 (6)
Si(4)	0.5000	0.1234 (6)	0.225 (3)	0.063 (6)
O(11)	0.2722 (15)	0.9815 (12)	0.461 (3)	0.070 (12)
O(12)	0.2285 (13)	0.1203 (10)	0.323 (4)	0.073 (10)
O(14)	0.4059 (12)	0.0731 (10)	0.278 (4)	0.066 (11)
O(22)	0.2722 (14)	0.2580 (14)	0.118 (4)	0.073 (13)
O(23)	0-4075 (12)	0.2780 (10)	0.776 (4)	0.077 (12)
O(34)	0.5000	0 1554 (16)	0.917 (5)	0.069 (16)
O(43)	0.2000	0.1966 (15)	0.423 (4)	0.063 (16)

all atoms, and weights  $1/[\sigma^2(F) + 0.00012F^2]$ , giving, for the larger data set, *i.e.* the merged data for two orientations, R = 0.116 (wR = 0.13) for 394 reflections with F > $6\sigma(F)$ . Atom parameters are listed in Table 1.\* An alternative refinement, using the first data set, *i.e.* for the crystal of lower rocking width only, gave R = 0.080 (wR = 0.09), but the atom parameters were not significantly different and the e.s.d.'s were larger.

The relatively high R values can be explained by a number of factors, including the large mosaic spread and the camera geometry (Andrews *et al.*, 1988).

## Results, comparison with powder diffraction study

Our results are in agreement, within 0.1-0.15 Å, with the structure as illustrated in the *c*-axis projection by High-cock, Smith & Wood (1985), but indicate substantial revision of some of the *z* coordinates, Si(3) and Si(4) by 0.5 Å, O(22), O(34) and O(43) by up to 1.5 Å. This does not alter the description of the structure as a three-

\* Lists of structure factors and anisotropic thermal parameters have been deposited with the British Library Document Supply Centre as Supplementary Publication No. SUP 52102 (5 pp.). Copies may be obtained through the Technical Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England.

## Table 2. Selected bond lengths (Å) and angles (°)

Si(1)-O(11)	1.61 (2)	Si(3)—O(23)	1.59 (2)
Si(1)—O(11 <sup>i</sup> )	1.58 (2)	Si(3)-O(23')	1.59 (2)
Si(1)-O(12)	1.59 (2)	Si(3)-O(34)	1.56 (2)
Si(1)-O(14)	1.60 (2)	Si(3)-O(43)	1.61 (2)
Si(2)-O(12)	1.62 (2)	Si(4)-O(14)	1.59 (2)
Si(2)-O(22)	1.62 (2)	Si(4)-O(14')	1.65 (2)
Si(2)—O(22")	1.59 (2)	Si(4)—O(34 <sup>vi</sup> )	1.62 (2)
Si(2)-O(23)	1.60 (2)	Si(4)-O(43)	1.65 (2)
Si(1)—O(11)—Si(1')	144.3 (1.3)	Si(2)-O(22 <sup>ii</sup> )-Si(2 <sup>ii</sup> )	151 7 (1-5)
Si(1)-O(12)-Si(2)	152.2 (1.4)	Si(2")—O(23)—Si(3)	151-5 (1-4)
Si(1)-O(14)-Si(4)	156-1 (1-3)	Si(3)-O(34)-Si(4 <sup>iii</sup> )	148 1 (1.5)
		Si(3)—O(43)—Si(4)	146.4 (1.4)
Symmetry code: (i) $x = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + z$ ; (v) $1 - x, y, z = -\frac{1}{2} + \frac{1}{2} + \frac{1}$	$y_{1} = y_{1} + z_{2}$ ; (ii) $\frac{1}{2}$ z; (vi) x, y, -1	$-x, \frac{1}{2}-y, \frac{1}{2}+z;$ (iii) $x, y, 1$ + $z$ .	+ z; (iv) x, - y

dimensional network of SiO<sub>4</sub> tetrahedra, sharing all corners, in such a way that there are large channels parallel to c. The revised Si and O atom positions do not differ significantly from those derived in a single-crystal study of silica-ZSM-22,  $24SiO_2(C_2H_3)_2NH$  (Marler, 1987), but the present material contains no organic guest molecules. Selected bond lengths and angles are given in Table 2.

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Structure of α-trans-cinnamic acid. Addendum. By DERK A. WIERDA, TIMOTHY L. FENG and ANDREW R. BARRON,\* Department of Chemistry, Harvard University, Cambridge, Massachusetts 02138, USA

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## Abstract

An addendum [Wierda, Feng & Barron (1989). Acta Cryst. C45, 838] of a recent report of a determination of the structure of the title compound [Wierda, Feng & Barron (1989). Acta Cryst. C45, 338-339] drew attention to a reference

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[Bryan & Freyberg (1975). J. Chem. Soc. Perkin Trans. 2, pp. 1835–1840] overlooked by the authors in their original report. The addendum failed to make clear that this reference contained a report of a complete room-temperature determination of the crystal structure in question. The two structures are in good agreement, except for variations attributed to differences in temperature.

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All relevant information is contained in the Abstract.